

L Number	Hits	Search Text	DB	Time stamp
1	463355	(memory or storage) near8 (die or circuit\$2 or ckt or device)	USPAT; US-PGPUB	2004/09/24 16:41
2	532	(memory or storage) near8 (dice)	USPAT; US-PGPUB	2004/09/24 16:41
3	1053770	test\$3	USPAT; US-PGPUB	2004/09/24 16:42
4	26493	test\$3 same (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))	USPAT; US-PGPUB	2004/09/24 16:44
5	95592	(repair\$3 or map\$4 or log\$4) same (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))	USPAT; US-PGPUB	2004/09/24 16:44
6	16492	test\$3 with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))	USPAT; US-PGPUB	2004/09/24 16:44
7	63219	(repair\$3 or map\$4 or log\$4) with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))	USPAT; US-PGPUB	2004/09/24 16:45
8	1542	(test\$3 with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)	USPAT; US-PGPUB	2004/09/24 16:46
9	2648	((repair\$3 or map\$4 or log\$4) with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)	USPAT; US-PGPUB	2004/09/24 16:46
10	44758	(memory or storage or die or dice) near8 (fail\$4 or defect\$4 or fault\$)	USPAT; US-PGPUB	2004/09/24 16:48
11	208	((test\$3 with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)) and (((repair\$3 or map\$4 or log\$4) with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)) and ((memory or storage or die or dice) near8 (fail\$4 or defect\$4 or fault\$))	USPAT; US-PGPUB	2004/09/24 16:51
12	3536	(714/718,719,723,735,736,819,820,824,710,711).ccls.	USPAT; US-PGPUB	2004/09/24 16:51
13	2110	(714/5,6,7).ccls.	USPAT; US-PGPUB	2004/09/24 16:52
14	2530	(324/759,765).ccls.	USPAT; US-PGPUB	2004/09/24 16:52
15	5581	(365/200,201).ccls.	USPAT; US-PGPUB	2004/09/24 16:52
16	161	((test\$3 with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)) and (((repair\$3 or map\$4 or log\$4) with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)) and ((memory or storage or die or dice) near8 (fail\$4 or defect\$4 or fault\$))) and (((714/718,719,723,735,736,819,820,824,710,711).ccls.))	USPAT; US-PGPUB	2004/09/24 16:53
17	6604	6rti((714/5,6,7).ccls.) or ((324/759,765).ccls.) or	USPAT; US-PGPUB	2004/09/24 16:53
18	17624	7(365/200,201).ccls.))	USPAT; US-PGPUB	2004/09/24 16:53

19	103	((((test\$3 with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)) and (((repair\$3 or map\$4 or log\$4) with (((memory or storage) near8 (die or circuit\$2 or ckt or device)) or ((memory or storage) near8 (dice)))) with (parallel or coincid\$ or simultaneous\$2)) and ((memory or storage or die or dice) near8 (fail\$4 or defect\$4 or fault\$))) and (((714/718,719,723,735,736,819,820,824,710,711).ccls.) or ((714/5,6,7).ccls.) or ((324/759,765).ccls.) or ((365/200,201).ccls.))) and (6.ti,ab,clm. and 7.ti,ab,clm.)	USPAT; US-PGPUB	2004/09/24 16:54
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